

Notice of References Cited

Application/Control No.

09/805,501

Patent(s)/Patent Under
Reexamination
STRATHMEYER ET AL.

Examiner

Van Kim T. Nguyen

Art Unit

2661

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,061,365	05-2000	Yeung et al.	370/470
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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